

# MOSFET – Power, Single P-Channel

-40 V, 69 m $\Omega$ , -13.2 A

### NVTFS052P04M8L

#### **Features**

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVTFWS052P04M8L Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR–Free and are RoHS Compliant

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parar	Symbol	Value	Unit		
Drain-to-Source Voltag	$V_{DSS}$	-40	V		
Gate-to-Source Voltage	Э		V <sub>GS</sub>	±20	V
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	-13.2	Α
Current R <sub>θJC</sub> (Notes 1, 2, 4)	Steady	T <sub>C</sub> = 100°C		-9.4	
Power Dissipation	State	T <sub>C</sub> = 25°C	$P_{D}$	23	W
R <sub>θJC</sub> (Notes 1, 2)		T <sub>C</sub> = 100°C		11.5	
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	-4.7	Α
Current R <sub>0JA</sub> (Notes 1, 3, 4)	Steady	T <sub>A</sub> = 100°C		-3.3	
Power Dissipation	State	T <sub>A</sub> = 25°C	$P_{D}$	2.9	W
R <sub>θJA</sub> (Notes 1, 3)		T <sub>A</sub> = 100°C		1.4	
Pulsed Drain Current	$T_A = 25^\circ$	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	46	Α
Operating Junction and Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C		
Source Current (Body D	I <sub>S</sub>	-19	Α		
Single Pulse Drain-to-S Energy (I <sub>L(pk)</sub> = -1.4 A)	E <sub>AS</sub>	54	mJ		
Lead Temperature for S (1/8" from case for 10 s		urposes	TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

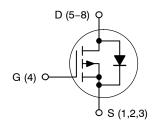
#### THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Drain) (Notes 1, 2 and 4)	$R_{ heta JC}$	6.5	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	52	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- Assumes heat-sink sufficiently large to maintain constant case temperature independent of device power.
- 3. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX	
-40 V	69 mΩ @ –10 V	-13.2 A	
	100 mΩ @ -4.5 V	-13.2 A	

#### P-Channel MOSFET





WDFN8 3.3x3.3, 0.65P CASE 511AB



WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL WF)
CASE 515AN

#### MARKING DIAGRAM



XXXX = Specific Device Code
A = Assembly Location

Y = Year
WW = Work Week
= Pb-Free Package

(Note: Microdot may be in either location)

#### ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

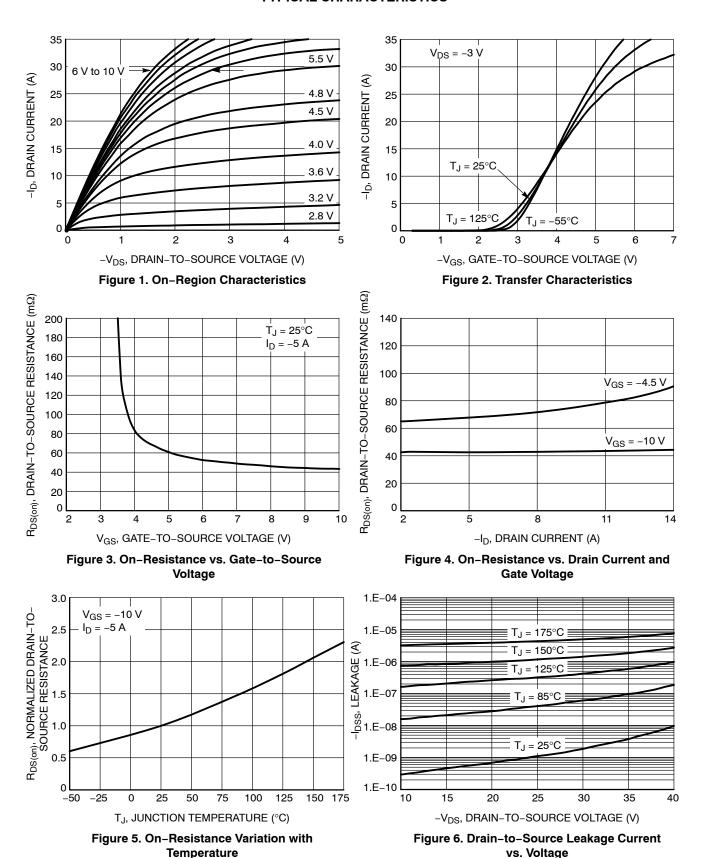
Parameter	Symbol	Test Condi	tion	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•	•			•	•	·
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D =$	-250 μΑ	-40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				23		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			-1.0	μΑ
		$V_{GS} = 0 \text{ V}, V_{DS} = -40 \text{ V}$	T <sub>J</sub> = 125°C			-1000	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)						-	
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	- –95 μA	-1.0		-2.4	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-5.5		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = -10 V, I <sub>E</sub>	<sub>)</sub> = -5 A		43.9	69	mΩ
		$V_{GS} = -4.5 \text{ V}, I_{D}$	= -2.5 A		66.5	100	1
Forward Transconductance	9FS	V <sub>DS</sub> = −1.5 V, I <sub>D</sub>	= -15 A		11		S
CHARGES AND CAPACITANCES	•				•	•	<u> </u>
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = -20 \text{ V}$			424		pF
Output Capacitance	C <sub>oss</sub>				161		1
Reverse Transfer Capacitance	C <sub>rss</sub>	v <sub>DS</sub> = -20	, v		9.3		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DS} = -20 \text{ V}; I_D = -10 \text{ A}$ $V_{GS} = -10 \text{ V}, V_{DS} = -20 \text{ V}; I_D = -10 \text{ A}$			3.0		nC
					6.3		
Threshold Gate Charge	Q <sub>G(TH)</sub>				0.8		
Gate-to-Source Charge	Q <sub>GS</sub>	Voc = -10 V Vp	s = -20 V		1.6		
Gate-to-Drain Charge	$Q_{GD}$	$V_{GS} = -10 \text{ V}, V_{DS}$ $I_{D} = -10$	A 20 V,		1.0		
Plateau Voltage	$V_{GP}$	1			3.7		V
SWITCHING CHARACTERISTICS, VG	is = -4.5 V (Not	te 6)			1		
Turn-On Delay Time	t <sub>d(on)</sub>				9.8		ns
Rise Time	t <sub>r</sub>	$V_{GS} = -4.5 \text{ V, } V_{DS}$	s = -20 V		28.5		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D = -10 \text{ A}, R_G$	$= 2.5 \Omega$		10.9		
Fall Time	t <sub>f</sub>	1			6.1		1
DRAIN-SOURCE DIODE CHARACTEI	RISTICS	•				1	
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V, I <sub>S</sub> = -5 A	T <sub>J</sub> = 25°C		-0.88	-1.25	V
		$I_S = -5 A$	T <sub>J</sub> = 125°C		-0.77		1
Reverse Recovery Time	t <sub>RR</sub>				21		ns
Charge Time	t <sub>a</sub>	Voo = 0 V dla/dt =	- 100 Δ/με		12.2		1
Discharge Time	t <sub>b</sub>	$V_{GS} = 0 \text{ V, dI}_S/\text{dt} = 100 \text{ A/}\mu\text{s,}$ $I_S = -10 \text{ A}$			8.8		1
Reverse Recovery Charge	Q <sub>RR</sub>				9.1	52	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2%.

6. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**



#### **TYPICAL CHARACTERISTICS**

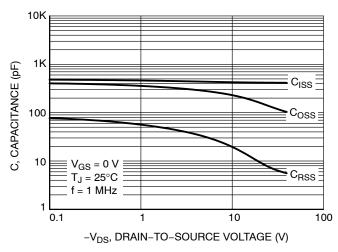


Figure 7. Capacitance Variation

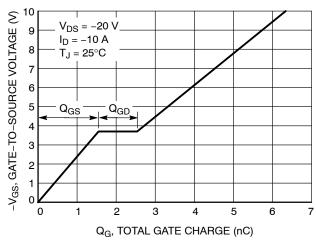


Figure 8. Gate-to-Source vs. Total Charge

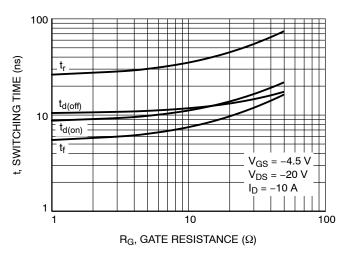


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

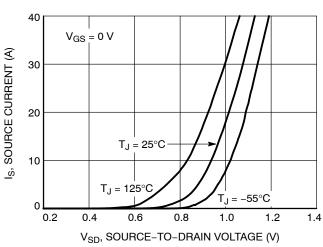


Figure 10. Diode Forward Voltage vs. Current

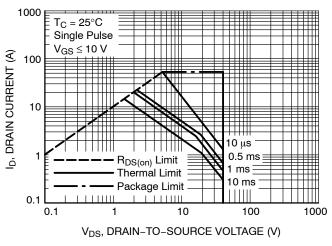


Figure 11. Maximum Rated Forward Biased Safe Operating Area

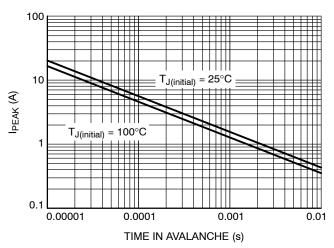


Figure 12. Maximum Drain Current vs. Time in Avalanche

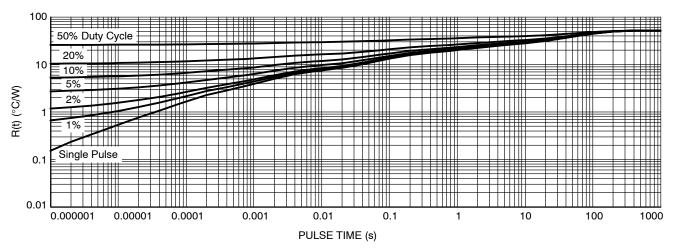


Figure 13. Thermal Response

#### **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NVTFS052P04M8LTAG	052M	WDFN8 3.3x3.3, 0.65P (Pb-Free)	1500 / Tape & Reel
NVTFWS052P04M8LTAG	052W	WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL WF) (Pb-Free, Wettable Flanks)	1500 / Tape & Reel

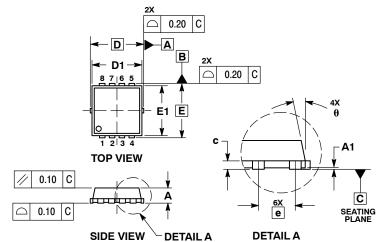
<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





#### WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

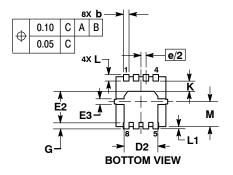
**DATE 23 APR 2012** 



#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  CONTROLLING DIMENSION: MILLIMETERS.
  DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
  PROTRUSIONS OR GATE BURRS.

	MILLIMETERS				<b>INCHES</b>		
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D		3.30 BSC		0.130 BSC			
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
E		3.30 BSC			0.130 BSC		
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е	0.65 BSC			(	0.026 BS0	2	
G	0.30	0.41	0.51	0.012	0.016	0.020	
K	0.65	0.80	0.95	0.026	0.032	0.037	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
М	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	

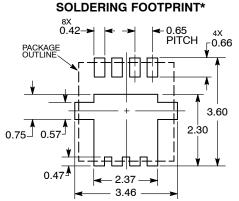


#### **GENERIC MARKING DIAGRAM\***



XXXXX = Specific Device Code = Assembly Location

= Year WW = Work Week = Pb-Free Package



DIMENSION: MILLIMETERS

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

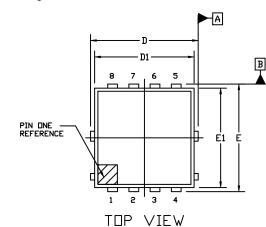
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<sup>\*</sup>This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

# WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL WF) CASE 515AN ISSUE O

**DATE 25 AUG 2020** 

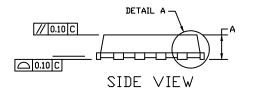


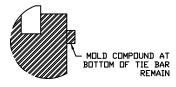


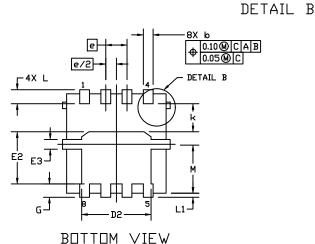
- 1. DIMENSIONING AND TOLERANCING PERASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

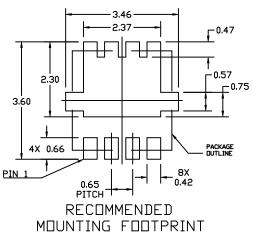
<u> </u>			ATED (	AREA
A1 I	DETAIL	<del>Т</del> А	C SEATIN PLANE	IG

	MILLIMETERS					
DIM	MIN.	NDM.	MAX.			
Α	0.70	0.75	0.80			
A1	0.00		0.05			
b	0.23	0.30	0.40			
c	0.15	0.20	0.25			
D	3.05	3.30	3.55			
D1	2.95	3.05	3.15			
D2	1.98	2.11	2.24			
Ε	3.05	3.30	3.55			
E1	2.95	3.05	3.15			
E2	1.47	1.60	1.73			
E3	0.23	0.30	0.40			
e		0.65 BSC				
G	0.30	0.41	0.51			
K	0.65	0.80	0.95			
L	0.30	0.43	0.59			
L1	0.06	0.13	0.20			
М	1.40	1.50	1.60			









\* For additional information on our Pb-Free strategy and soldering details, please download the DN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

### GENERIC MARKING DIAGRAM\*

XXXX AYWW• XXXX = Specific Device Code

A = Assembly Location

Y = Year

WW = Work Week

= Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

(Note: Microdot may be in either location)

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DESCRIPTION:	WDFNW8 3.3x3.3, 0.65P (F	WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL WF)			

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